



PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

NEW Atty. Dkt. No.: 2775-001

Elwin M. BEATY et al.

OLD Atty. Dkt. No.: 2371

Appln. No.: 09/351,892

Group Art Unit: 2621

Filed: July 13, 1999

Examiner: S. Chawan

Title: METHOD AND APPARATUS FOR THREE  
DIMENSIONAL INSPECTION OF  
ELECTRONIC COMPONENTS

\* \* \* \* \* \* \* \* \* \* \* \* \* \* \*  
AMENDMENT UNDER 37 C.F.R. § 1.111  
\* \* \* \* \* \* \* \* \* \* \* \* \* \* \*

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Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

MAY 29 2003  
Technology Center 2600

Dear Sir:

In reply to the Office Action mailed December 23, 2002, the period for reply having been extended by petition to May 23, 2003, and pursuant to the filing herewith of a Request for Continued Examination, please amend the above-identified patent application as follows:

IN THE SPECIFICATION:

Amend the paragraphs from page 6, line 12 through page 7, line 10 to read as follows:

B1 The invention further provides for using a part definition file that contains measurement values for an ideal part, calculating an expected position for each lead of the part for a